

<b>Notice of References Cited</b>		Application/Control No. 10/049,642	Applicant(s)/Patent Under Reexamination OTTERS BACH ET AL.
		Examiner Tae H Yoon	Art Unit 1714

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,588,781	05-1986	Ohmori et al.	525/200
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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